

REFERENCE DESIGNATION U.S. PATENT DOCUMENTS

| EXAMINER<br>INITIAL |    | DOCUMENT NUMBER Number-Kind Code (if known) | DATE     | NAME          | CLASS/<br>SUBCLASS | FILING<br>DATE |
|---------------------|----|---|----------|---------------|--------------------|----------------|
| XX                  | A1 | 5,422,724                                   | 06/06/95 | Kinney et al. |                    |                |

**FOREIGN PATENT DOCUMENTS** 

| EXAMINER<br>INITIAL |    | DOCUMENT NUMBER Number-Kind Code (If known) | DATE     | COUNTRY | CLASS/<br>SUBCLASS | TRANSLATION<br>YES OR NO |
|---------------------|----|---|----------|---------|--------------------|--------------------------|
| RU                  | A2 | DE 198 47 631 A1                            | 10/15/98 | Germany |                    |                          |

| EXAMINER INITIAL | OTHER ART – NON PATENT LITERATURE DOCUMENTS  (Include name of author, title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date page(s), volume-issue number(s), publisher, city and/or country where published. |  |
|------------------|---|--|
| Du               | A3  | C. Lakshminarayan, "Overview of outlier methods in SC manufacturing", TI Technical Journal, pages 54-56, October-December 1998 |

| EXAMINER | 0 1 4  | DATE CONSIDERED / / |
|----------|--------|---------------------|
| hallea   | School | 9/16/00             |

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.